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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination PICKERING ET AL. | |
| | | Examiner Krista M. Flanagan | Art Unit 2631 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------------------------|----------------|
| | A | US-5,635,862 | 06-1997 | Abramson et al. | 326/105 |
| | B | US-6,229,472 | 05-2001 | Nishida, Yoshio | 341/161 |
| | C | US-5,761,244 | 06-1998 | Hedberg, Mats Olof Joakim | 375/257 |
| | D | US-6,525,559 | 02-2003 | Wu et al. | 326/30 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|-------------------------------------------------------------------------------------------|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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